

INTERNATIONAL STANDARD

Active millimetre-wave systems for security screening of humans – General requirements



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CONTENTS

FOREWORD	4
1 Scope	6
2 Normative references	6
3 Terms and definitions	7
4 Requirements and tests	9
4.1 Environmental conditions	9
4.2 Major test instruments and tools	9
4.3 Appearance and structure	10
4.3.1 Requirements	10
4.3.2 Test method	10
4.4 Functionality	10
4.4.1 Requirements	10
4.4.2 Test method	11
4.5 Performance	13
4.5.1 Imaging performance test methods	13
4.5.2 Detection time test method	14
4.6 Power requirements and testing	14
4.6.1 Requirements	14
4.6.2 Test method	14
4.7 Safety	15
4.7.1 Electromagnetic radiation safety	15
4.7.2 Electrical safety	17
4.7.3 Mechanical safety	17
4.8 Electromagnetic compatibility	17
4.8.1 Electromagnetic Immunity	17
4.8.2 Electromagnetic interference	18
4.9 System noise	18
4.10 Environmental compliance testing	18
4.10.1 General	18
4.10.2 Environmental tests	18
4.11 Mechanical compliance testing	19
4.11.1 General	19
4.11.2 Mechanical tests	19
4.12 Testing overview	20
5 Marking and documentation	20
Annex A (informative) Testing overview	21
A.1 General	21
A.2 Test overview	22
Figure 1 – L-shaped metal object	13
Figure 2 – Ceramic bar partially covered with plastic	13
Figure 3 – Metal bar covered with plastic	13
Figure 4 – Diagram of the coordinate system	16

Table 1 – Major instruments and tools	9
Table 2 – Man-made fault conditions	11
Table 3 – ATR test items	12
Table 4 – ATR test positions	12
Table 5 – Test conditions of the supplies	14
Table 6 – The specified positions inside the system	16
Table 7 – The specified positions outside the system	16
Table 8 – Environmental tests	19
Table 9 – Mechanical tests	20
Table A.1 – Test overview	22

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ACTIVE MILLIMETRE-WAVE SYSTEMS FOR SECURITY
SCREENING OF HUMANS – GENERAL REQUIREMENTS**

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Draft	Report on voting
45B/1064/FDIS	45B/1072/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

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- reconfirmed,
- withdrawn, or
- revised.

ACTIVE MILLIMETRE-WAVE SYSTEMS FOR SECURITY SCREENING OF HUMANS – GENERAL REQUIREMENTS

1 Scope

This document applies to security screening systems that utilize active millimetre-wave (MMW) imaging to inspect persons who are not inside vehicles, containers, or enclosures. Specifically, this document applies to systems used to detect objects carried on the body of the individual being screened at a security checkpoint. This document applies to systems that screen people using radiation in the range between 3 GHz and 150 GHz (100 mm to 2 mm).

This document specifies the technical requirements, test methods, and signage of the active MMW systems for security screening of humans.

This document does not specify minimum or baseline requirements of image quality, automated threat recognition (ATR) performance, nor does it specify a minimum detection time.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60068-2-1:2007, *Environmental testing – Part 2-1: Tests – Test A: Cold*

IEC 60068-2-2:2007, *Environmental testing – Part 2-2: Tests – Test B: Dry heat*

IEC 60068-2-6:2007, *Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-27:2008, *Environmental testing – Part 2-27: Tests – Test Ea and guidance: Shock*

IEC 60068-2-78:2012, *Environmental testing – Part 2-78: Tests – Test Cab: Damp heat, steady state*

IEC 60204-1:2016, *Safety of machinery – Electrical equipment of machines – Part 1: General requirements*

IEC 60204-1:2016/AMD1:2021

IEC 60529:1989, *Degrees of protection provided by enclosures (IP Code)*

IEC 60529:1989/AMD1:1999

IEC 60529:1989/AMD2:2013

IEC 61000-4-2:2008, *Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test*

IEC 61000-4-3:2020, *Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated, radio-frequency, electromagnetic field immunity test*

IEC 61000-4-4:2012, *Electromagnetic compatibility (EMC) – Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test*